

# SKM600GA12F4



SEMITRANS® 4

## High Speed IGBT4 Modules

### SKM600GA12F4

#### Features\*

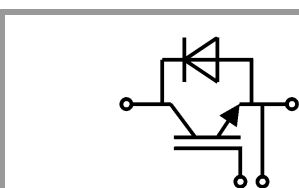
- High speed trench and field-stop IGBT
- CAL4 ultra-fast = soft switching 4. generation CAL-diode
- Insulated copper baseplate using DBC technology (Direct Bonded Copper)
- Increased power cycling capability
- For higher switching frequencies above 15kHz
- UL recognized, file no. E63532

#### Typical Applications

- Resonant inverters
- Inductive heating
- Electronic welders

#### Remarks

- Case temperature limited to  $T_c = 125^\circ\text{C}$  max.
- Recommended  $T_{j,op} = -40 \dots +150^\circ\text{C}$
- Product reliability results valid for  $T_j = 150^\circ\text{C}$



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| Absolute Maximum Ratings |  |                           |             |                  |
|--------------------------|--|---------------------------|-------------|------------------|
| Symbol                   | Conditions   |                           | Values      | Unit             |
| <b>IGBT</b>              |  |                           |             |                  |
| $V_{CES}$                |  |                           | 1200        | V                |
| $I_C$                    | $T_j = 175^\circ\text{C}$  | $T_c = 25^\circ\text{C}$  | 854         | A                |
|                          |  | $T_c = 80^\circ\text{C}$  | 652         | A                |
| $I_{Cnom}$               |  |                           | 600         | A                |
| $I_{CRM}$                |  |                           | 1200        | A                |
| $V_{GES}$                |  |                           | -20 ... 20  | V                |
| $t_{psc}$                | $V_{CC} = 800\text{ V}$<br>$V_{GE} \leq 15\text{ V}$<br>$V_{CES} \leq 1200\text{ V}$ | $T_j = 150^\circ\text{C}$ | 10          | $\mu\text{s}$    |
|                          |  |                           |             |                  |
| $T_j$                    |  |                           | -40 ... 175 | $^\circ\text{C}$ |
| <b>Inverse diode</b>     |  |                           |             |                  |
| $V_{RRM}$                | $T_j = 25^\circ\text{C}$   |                           | 1200        | V                |
| $I_F$                    | $T_j = 175^\circ\text{C}$  | $T_c = 25^\circ\text{C}$  | 669         | A                |
|                          |  | $T_c = 80^\circ\text{C}$  | 490         | A                |
| $I_{FRM}$                |  |                           | 1200        | A                |
| $I_{FSM}$                | $t_p = 10\text{ ms, sin } 180^\circ, T_j = 25^\circ\text{C}$                         |                           | 2752        | A                |
| $T_j$                    |  |                           | -40 ... 175 | $^\circ\text{C}$ |
| <b>Module</b>            |  |                           |             |                  |
| $I_{t(RMS)}$             |  |                           | 500         | A                |
| $T_{stg}$                | module without TIM   |                           | -40 ... 125 | $^\circ\text{C}$ |
| $V_{isol}$               | AC sinus 50 Hz, $t = 1\text{ min}$   |                           | 4000        | V                |

| Characteristics |   |                           |      |       |       |                  |
|-----------------|---|---------------------------|------|-------|-------|------------------|
| Symbol          | Conditions  |                           | min. | typ.  | max.  | Unit             |
| <b>IGBT</b>     |   |                           |      |       |       |                  |
| $V_{CE(sat)}$   | $I_C = 600\text{ A}$<br>$V_{GE} = 15\text{ V}$<br>chipelevel                          | $T_j = 25^\circ\text{C}$  | 2.05 | 2.42  |       | V                |
|                 |   | $T_j = 150^\circ\text{C}$ | 2.57 | 2.99  |       | V                |
| $V_{CE0}$       | chipelevel  | $T_j = 25^\circ\text{C}$  | 1.10 | 1.28  |       | V                |
|                 |   | $T_j = 150^\circ\text{C}$ | 0.95 | 1.13  |       | V                |
| $r_{CE}$        | $V_{GE} = 15\text{ V}$<br>chipelevel  | $T_j = 25^\circ\text{C}$  | 1.58 | 1.90  |       | $\text{m}\Omega$ |
|                 |   | $T_j = 150^\circ\text{C}$ | 2.7  | 3.1   |       | $\text{m}\Omega$ |
| $V_{GE(th)}$    | $V_{GE} = V_{CE}, I_C = 20.8\text{ mA}$   |                           | 5.2  | 5.8   | 6.4   | V                |
| $I_{CES}$       | $V_{GE} = 0\text{ V}, V_{CE} = 1200\text{ V}, T_j = 25^\circ\text{C}$                 |                           |      |       | 5     | mA               |
| $C_{ies}$       | $V_{CE} = 25\text{ V}$<br>$V_{GE} = 0\text{ V}$                                       | $f = 1\text{ MHz}$        | 35.2 |       |       | nF               |
| $C_{oes}$       |   | $f = 1\text{ MHz}$        | 2.32 |       |       | nF               |
| $C_{res}$       |   | $f = 1\text{ MHz}$        | 1.88 |       |       | nF               |
| $Q_G$           | $V_{GE} = -8\text{ V} \dots +15\text{ V}$   |                           | 3400 |       |       | nC               |
| $R_{Gint}$      | $T_j = 25^\circ\text{C}$  |                           | 0.9  |       |       | $\Omega$         |
| $t_{d(on)}$     | $V_{CC} = 600\text{ V}$<br>$I_C = 600\text{ A}$<br>$V_{GE} = +15/-15\text{ V}$        | $T_j = 150^\circ\text{C}$ | 106  |       |       | ns               |
| $t_r$           |   | $T_j = 150^\circ\text{C}$ | 80   |       |       | ns               |
| $E_{on}$        | $R_{G on} = 2\ \Omega$  | $T_j = 150^\circ\text{C}$ | 32   |       |       | mJ               |
| $t_{d(off)}$    | $R_{G off} = 4.4\ \Omega$   | $T_j = 150^\circ\text{C}$ | 682  |       |       | ns               |
| $t_f$           | $di/dt_{on} = 7100\text{ A}/\mu\text{s}$<br>$di/dt_{off} = 6100\text{ A}/\mu\text{s}$ | $T_j = 150^\circ\text{C}$ | 70   |       |       | ns               |
|                 |   | $T_j = 150^\circ\text{C}$ | 51   |       |       | mJ               |
| $E_{off}$       |   |                           |      | 51    |       | mJ               |
| $R_{th(j-c)}$   | per IGBT  |                           |      |       | 0.045 | K/W              |
| $R_{th(c-s)}$   | per IGBT, P12 (reference)   |                           |      | 0.021 |       | K/W              |
| $R_{th(c-s)}$   | per IGBT, HP-PCM  |                           |      | 0.012 |       | K/W              |



**SEMITRANS® 4**

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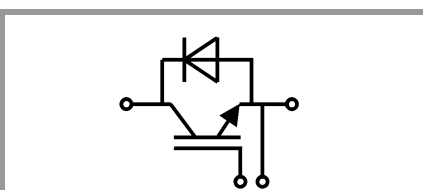
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- Electronic welders

#### Remarks

- Case temperature limited to  $T_c = 125^\circ\text{C}$  max.
- Recommended  $T_{j,op} = -40 \dots +150^\circ\text{C}$
- Product reliability results valid for  $T_j = 150^\circ\text{C}$

| Characteristics      |  |                           | min. | typ.   | max.  | Unit          |
|----------------------|--|---------------------------|------|--------|-------|---------------|
| Symbol               | Conditions   |                           |      |        |       |               |
| <b>Inverse diode</b> |  |                           |      |        |       |               |
| $V_F = V_{EC}$       | $I_F = 600\text{ A}$<br>$V_{GE} = 0\text{ V}$<br>chipelevel          | $T_j = 25^\circ\text{C}$  |      | 2.43   | 2.80  | V             |
|                      |  | $T_j = 150^\circ\text{C}$ |      | 2.30   | 2.65  | V             |
| $V_{F0}$             | chipelevel   | $T_j = 25^\circ\text{C}$  |      | 1.51   | 1.75  | V             |
|                      |  | $T_j = 150^\circ\text{C}$ |      | 1.16   | 1.40  | V             |
| $r_F$                | chipelevel   | $T_j = 25^\circ\text{C}$  |      | 1.54   | 1.74  | m $\Omega$    |
|                      |  | $T_j = 150^\circ\text{C}$ |      | 1.90   | 2.1   | m $\Omega$    |
| $I_{RRM}$            | $I_F = 600\text{ A}$   | $T_j = 150^\circ\text{C}$ |      | 560    |       | A             |
| $Q_{rr}$             | $di/dt_{off} = 7000\text{ A}/\mu\text{s}$                            | $T_j = 150^\circ\text{C}$ |      | 71     |       | $\mu\text{C}$ |
| $E_{rr}$             | $V_{GE} = -15\text{ V}$<br>$V_{CC} = 600\text{ V}$                   | $T_j = 150^\circ\text{C}$ |      | 36     |       | mJ            |
| $R_{th(j-c)}$        | per diode  |                           |      |        | 0.085 | K/W           |
| $R_{th(c-s)}$        | per diode, P12 (reference)   |                           |      | 0.024  |       | K/W           |
| $R_{th(c-s)}$        | per diode, HP-PCM  |                           |      | 0.013  |       | K/W           |
| <b>Module</b>        |  |                           |      |        |       |               |
| $L_{CE}$             |  |                           |      | 15     |       | nH            |
| $R_{CC+EE}$          | measured per switch  | $T_c = 25^\circ\text{C}$  |      | 0.18   |       | m $\Omega$    |
|                      |  | $T_c = 125^\circ\text{C}$ |      | 0.22   |       | m $\Omega$    |
| $R_{th(c-s)1}$       | calculated without thermal coupling                                  |                           |      | 0.0112 |       | K/W           |
| $R_{th(c-s)2}$       | including thermal coupling, $T_s$ underneath module, P12 (reference) |                           |      | 0.018  |       | K/W           |
| $R_{th(c-s)2}$       | including thermal coupling, $T_s$ underneath module, HP-PCM          |                           |      | 0.010  |       | K/W           |
| $M_s$                | to heat sink M6  |                           | 3    |        | 5     | Nm            |
| $M_t$                | to terminals   | M6                        | 2.5  |        | 5     | Nm            |
|                      |  | M4                        | 1.1  |        | 2     | Nm            |
| w                    |  |                           |      |        | 330   | g             |



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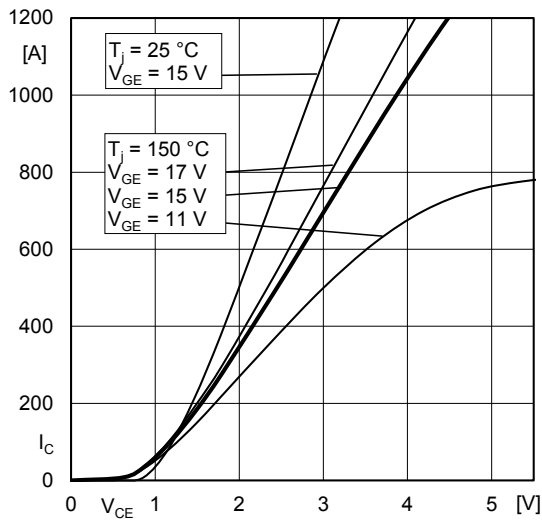


Fig. 1: Typ. output characteristic, inclusive  $R_{CC+EE}$

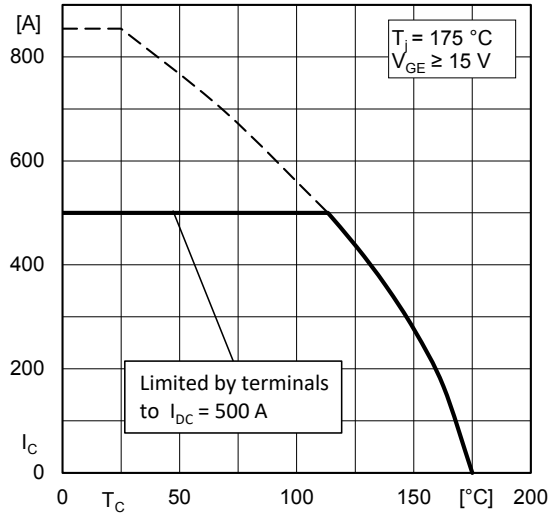


Fig. 2: Rated current vs. temperature  $I_C = f(T_C)$

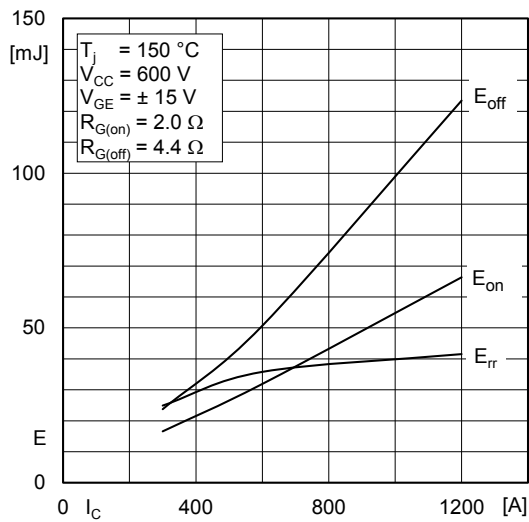


Fig. 3: Typ. turn-on /-off energy =  $f(I_C)$

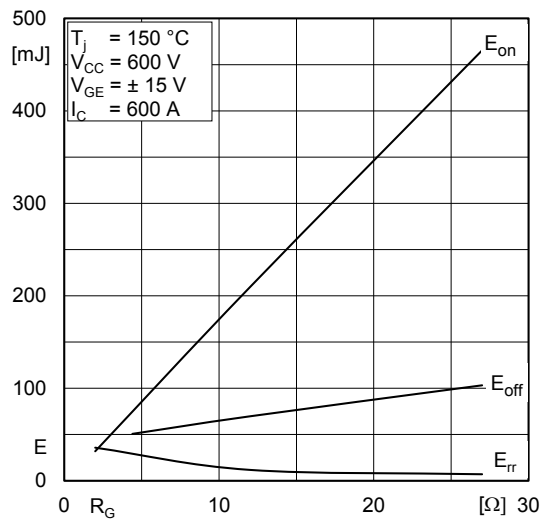


Fig. 4: Typ. turn-on /-off energy =  $f(R_G)$

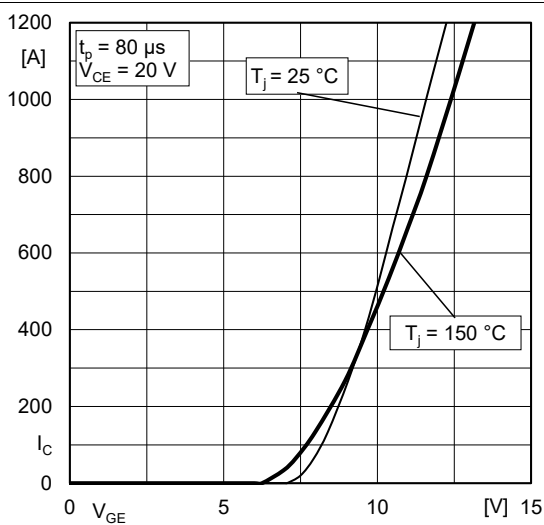


Fig. 5: Typ. transfer characteristic

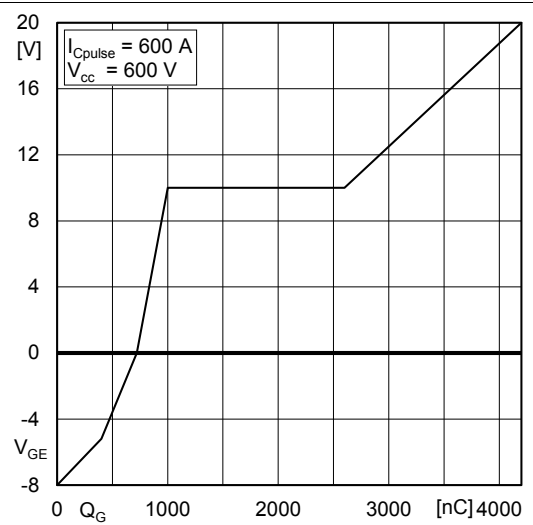


Fig. 6: Typ. gate charge characteristic

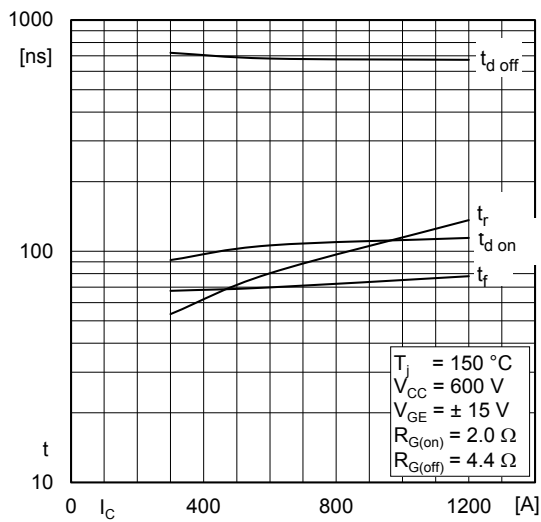


Fig. 7: Typ. switching times vs.  $I_C$

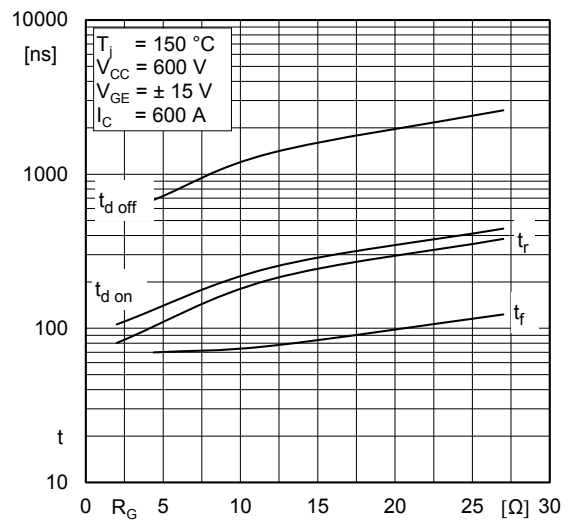


Fig. 8: Typ. switching times vs. gate resistor  $R_G$

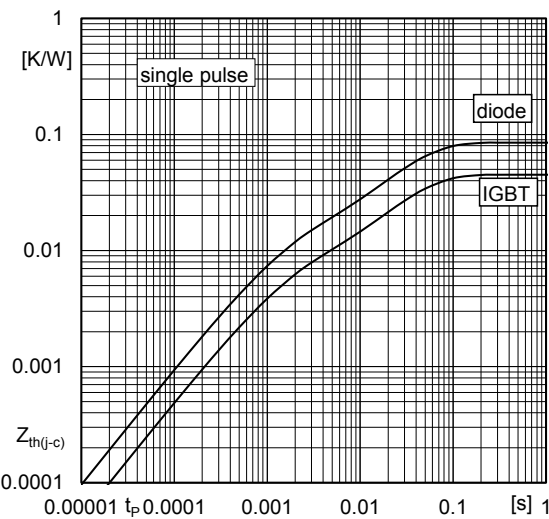


Fig. 9: Transient thermal impedance

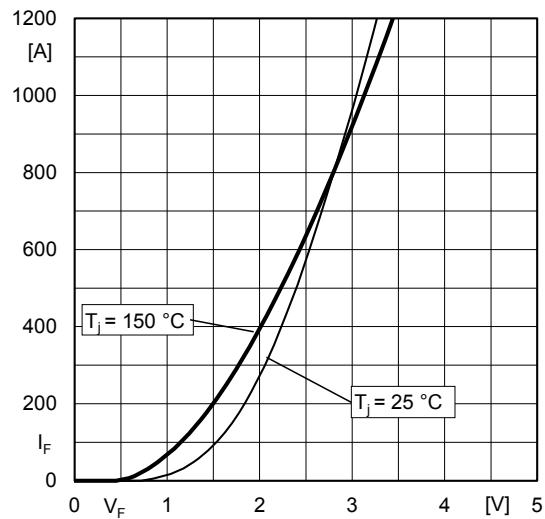


Fig. 10: Typ. CAL diode forward charact., incl.  $R_{CC+EE}$

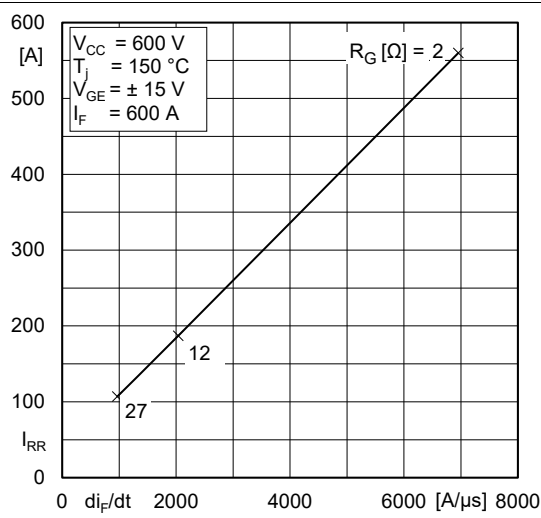


Fig. 11: Typ. CAL diode peak reverse recovery current

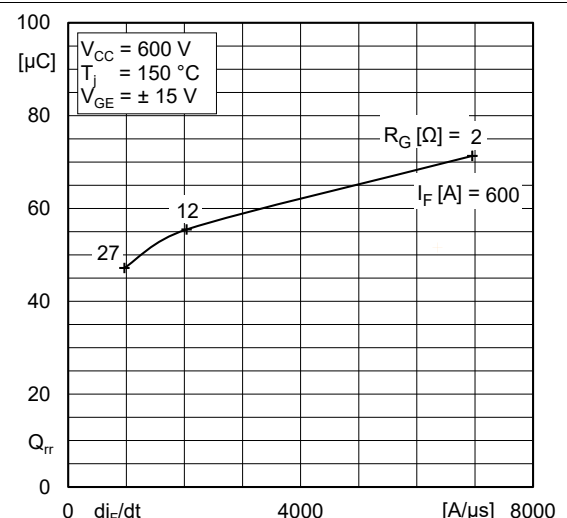
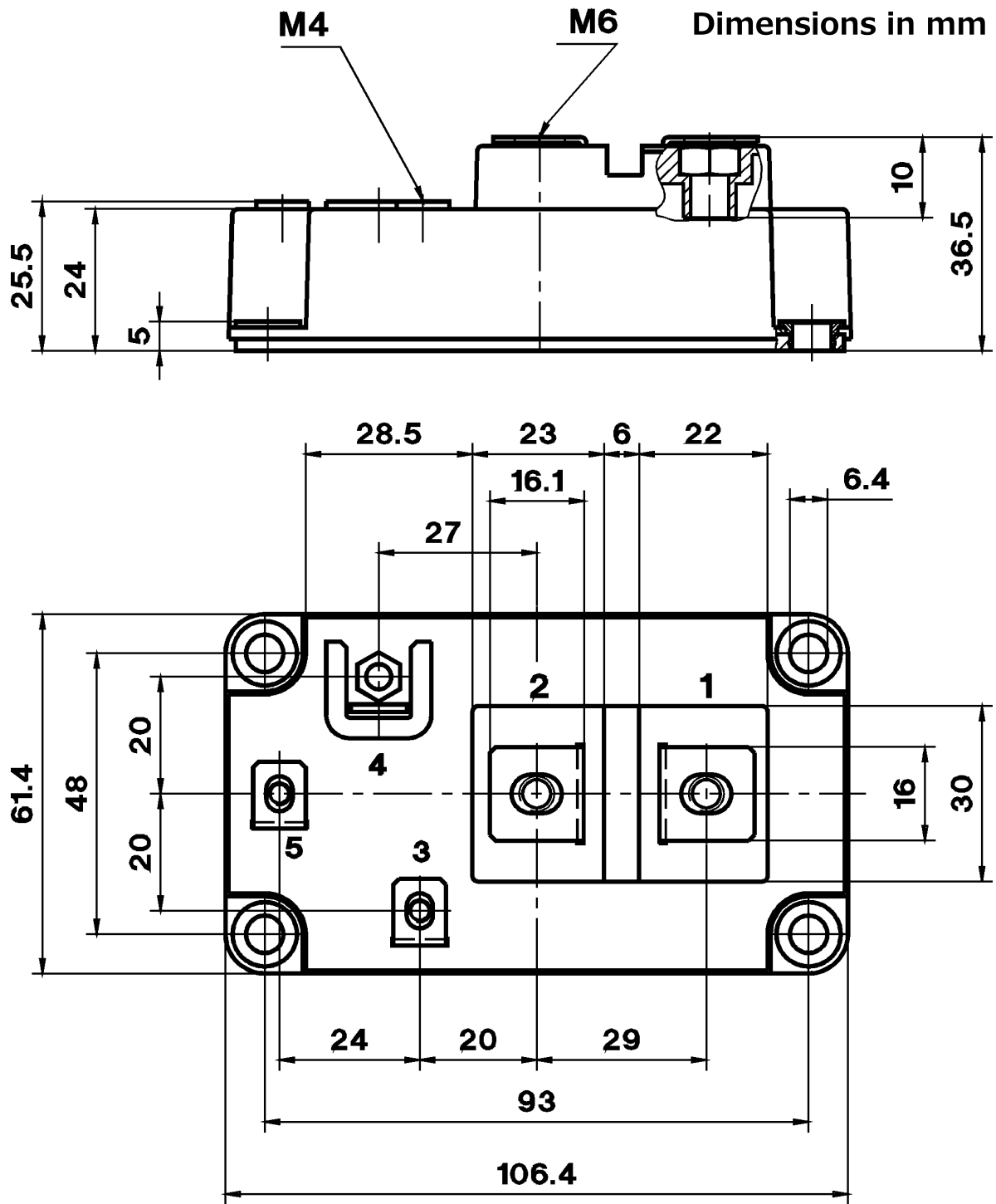
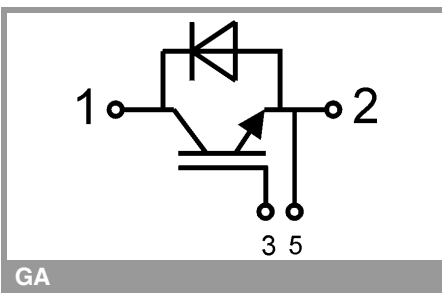


Fig. 12: Typ. CAL diode peak reverse recovery charge



General tolerance  $\pm 0.5$  mm

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## IMPORTANT INFORMATION AND WARNINGS

This is an electrostatic discharge sensitive device (ESDS) according to international standard IEC 61340.

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